

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
		09/466,279	Examiner	Art Unit Brian Shelton
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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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E	US-			
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J	US-			
K	US-			
L	US-			
M	US-			

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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